

FCC/ISED

EMC

TEST REPORT

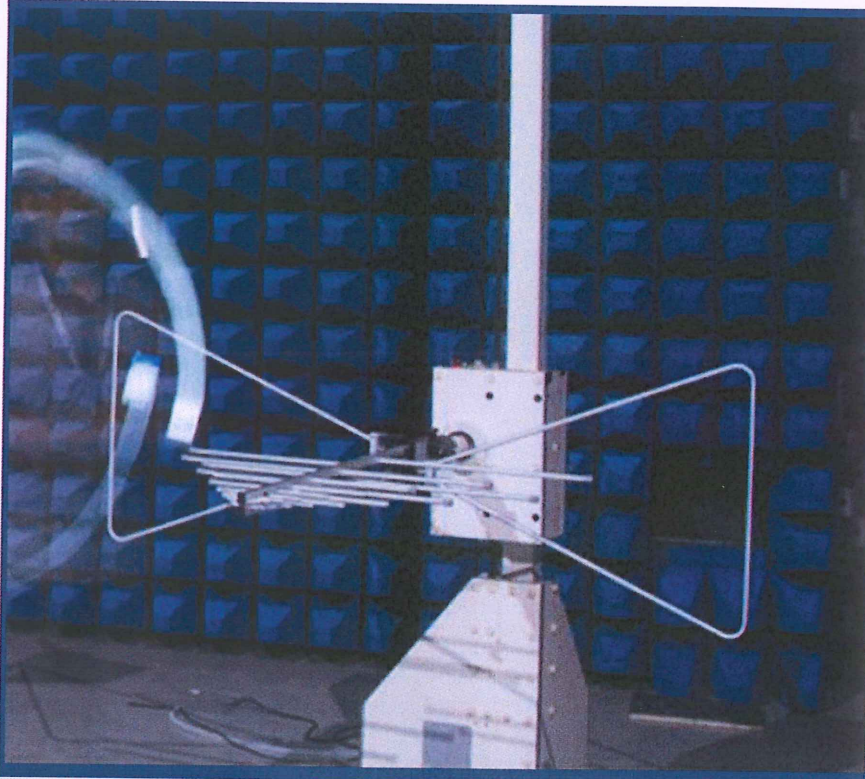
ISSUED BY
Shenzhen BALUN Technology Co., Ltd.



FOR
Rugged Smart Phone

ISSUED TO
Shenzhen UniStrong Science & Technology Co., Ltd.

B,4-4Factory, Zhengcheng Road, FuyongBaoan District, Shenzhen,
China



Tested by: Xia Long
Xia Long
(Engineer)

Date Mar. 15. 2019

Approved by: Wei Yanquan
Wei Yanquan
(Chief Engineer)

Date Mar. 15. 2019

Report No.: BL-EC1930222-401

EUT Name: Rugged Smart Phone

Model Name: UT12

Brand Name: UniStrong

Test Standard: 47 CFR Part 15 Subpart B
ICES-003 (Issue 6, January 2016)

Test Conclusion: Pass

Test Date: Mar. 11, 2019

Date of Issue: Mar. 15, 2019

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Revision History

Version	Issue Date	Revisions Content
<u>Rev. 01</u>	<u>Mar. 15, 2019</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co.,Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100
Fax Number	+86 755 6182 4271

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co.,Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 11524A-1. The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The laboratory is a testing organization accredited by American Association for Laboratory Accreditation(A2LA) according to ISO/IEC 17025.The accreditation certificate is 4344.01. The laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L6791.
Description	All measurement facilities used to collect the measurement data are located at Block B, FL 1, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China 518055

1.3 Laboratory Condition

Ambient Temperature	20°C to 25°C
Ambient Relative Humidity	45% to 55%
Ambient Pressure	100 kPa to 102 kPa

1.4 Announce

- (1) The test report refer to the BALUN report mode v6.7.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Shenzhen UniStrong Science & Technology Co.,Ltd.
Address	B,4-4Factory, Zhengcheng Road, FuyongBaoan District, Shenzhen, China

2.2 Manufacturer Information

Manufacturer	Shenzhen UniStrong Science & Technology Co.,Ltd.
Address	B,4-4Factory, Zhengcheng Road, FuyongBaoan District, Shenzhen, China

2.3 Factory Information

Factory	N/A
Address	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Name	Rugged Smart Phone
Model Name Under Test	UT12
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	N/A
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.5 Ancillary Equipment

Ancillary Equipment 1	Battery	
	Brand Name	SJYEnergy
	Model No.	BA7800
	Serial No.	N/A
	Capacity	8000 mAh
	Rated Voltage	3.8 V
	Limit Charge Voltage	4.35 V
Ancillary Equipment 2	Adapter	
	Brand Name	N/A
	Model No.	ASUC71W
	Serial No.	N/A
	Rated Input	100-240 V~, 0.7 A, 50/60 Hz
	Rated Output	5 V= 3 A
Ancillary Equipment 3	USB Cable	
	Model No.	N/A
	Length (Approx.)	1 m

2.6 Technical Information

Network and Wireless connectivity	GSM/GPRS/EGPRS 850/900/1800/1900 MHz; CDMA Band Class 0; EVDO Rel. 0/Rev. A Band Class 0; WCDMA/HSDPA/HSUPA Band 1/2/5/8; LTE FDD Band 1/2/3/4/5/7/8/17/20/28; LTE TDD Band 38/40/41; Bluetooth, GPS, GLONASS, NFC, BDS
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3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	FCC 47 CFR Part 15 Subpart B (10-1-17 Edition)	Unintentional Radiators
2	ICES-003 (Issue 6, January 2016)	Information Technology Equipment (Including Digital Apparatus) — Limits and Methods of Measurement
3	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Result
1	Radiated Emission	15.109	Pass	Annex A .1
2	Conducted Emission, AC Ports	15.107	Pass	Annex A .2

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.23 dB
Radiated emissions (30 MHz-1 GHz)	4.30 dB
Radiated emissions (1 GHz-18 GHz)	4.81 dB
Radiated emissions (18 GHz-40 GHz)	5.71 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments

Environment Parameter	Selected Values During Tests			
	Temperature	Voltage	Relative Humidity	Ambient Pressure
Normal Temperature, Normal Voltage (NTNV)	23°C to 25°C	AC 120 V/60 Hz or DC 3.7 V from Battery	50% to 55%	100 kPa to 102 kPa

4.2 Test Equipment List

Radiated Emission Test For Frequency Below 1 GHz						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2018.06.13	2019.06.12	☒
Test Antenna-Bi-Log	SCHWARZBECK	VULB 9163	9163-977	2017.07.22	2019.07.21	☒
Test Antenna-Horn	SCHWARZBECK	BBHA 9120D	9120D-1600	2018.07.11	2020.07.10	☐
Anechoic Chamber	EMC Electronic Co., Ltd	9m*6m*6m	N/A	2017.02.21	2020.02.20	☒
Test Software	BALUN	BL410_E	V18.626	--	--	☒

Radiated Emission Test For Frequency Above 1 GHz						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9038A	MY53220118	2018.11.07	2019.11.06	☒
Test Antenna-Bi-Log	SCHWARZBECK	VULB 9163	9163-624	2017.07.22	2019.07.21	☐
Test Antenna-Horn	SCHWARZBECK	BBHA 9120D	9120D-1148	2018.07.11	2020.07.10	☒
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.21	2020.02.20	☒
Test Software	BALUN	BL410_E	V18.626	--	--	☒

Conducted Emission Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2018.06.13	2019.06.12	☒
LISN	SCHWARZBECK	NSLK 8127	8127-687	2018.06.13	2019.06.12	☒
LISN	SCHWARZBECK	NNLK 8129	8129-462	2018.11.07	2019.11.06	☐
ISN	TESEQ	ISN T800	34449	2017.12.05	2019.12.04	☐
Shielded Enclosure	ChangNing	CN-130701	130703	N/A	N/A	☒
Test Software	BALUN	BL410_E	V18.626	--	--	☒

4.3 Test Enclosure list

Description	Manufacturer	Model	Serial No.	Length	Description	Use
PC	N/A	N/A	N/A	N/A	Special Handled	☐
Laptop	Apple	A1465	N/A	N/A	N/A	☒
Printer	HP	DESKJET 1000	N/A	N/A	N/A	☐
Keyboard	Logitech	Y-BP62a	N/A	N/A	N/A	☐
Mouse	Logitech	M100	N/A	N/A	N/A	☐
USB disk	Kingston	N/A	N/A	N/A	N/A	☐
TF Card	Kingston	N/A	N/A	N/A	N/A	☒
VGA Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
HDMI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
DVI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
Coaxial video cable	N/A	N/A	N/A	2.0 m	Shielded with core	☐
Audio Cable	N/A	N/A	N/A	0.5 m	Shielded with core	☐
iPhone	Apple	A1586	N/A	N/A	N/A	☐
Bluetooth Earphone	SAMSUNG	Gear Circle	N/A	N/A	N/A	☒
Wireless Communications Test Set	R&S	CMW500	142028	N/A	Cal. Due 2019.06.14	☐
WIFI Router	TP-LINK	TL-WDR7500	N/A	N/A	N/A	☐
GPS/GLONASS Vector signal generator	R&S	N5172B EXG	N/A	N/A	N/A	☒
Car Battery	Camel	55530	N/A	N/A	12 V/55 Ah	☐
Artificial load	N/A	N/A	N/A	N/A	2.5 Ω /100 W	☐
Artificial load	N/A	N/A	N/A	N/A	5 Ω /100 W	☐
Electronic Load	ITECH	IT8511	N/A	N/A	N/A	☐
USB Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
DC Power Supply	ITECH	IT6863A	60001401068 7210006	N/A	N/A	☐
LCD Monitor	SAMSUNG	UA32C4000P	N/A	N/A	N/A	☐
RJ45 Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
IC Card	N/A	N/A	N/A	N/A	N/A	☒

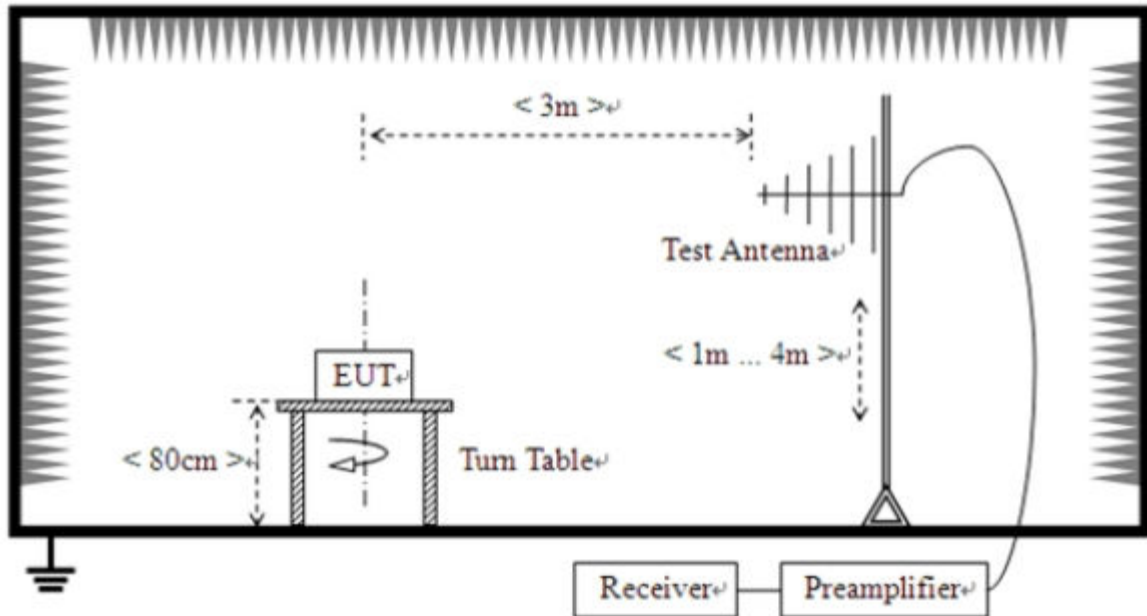
4.4 Test Configurations

Test Configurations (TC) No.	Description
Traffic Test Mode	
TC01	<u>The GSM 850 MHz Test Mode</u> GSM 850 Link + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC02	<u>The EDGE 850 MHz Test Mode</u> EDGE 850 Link + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC03	<u>The GSM 1900 Test Mode</u> GSM 1900 Link + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC04	<u>The EDGE 1900 MHz Test Mode</u> EDGE 1900 Link + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC05	<u>The WCDMA Band 2 Test Mode</u> WCDMA Band 2 + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC06	<u>The WCDMA Band 5 Test Mode</u> WCDMA Band 5 + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC07	<u>The CDMA Test Mode</u> CDMA + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC08	<u>The EVDO Test Mode</u> EVDO + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC09	<u>The FDD LTE Band 2 Test Mode</u> LTE Band 2 Link + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC10	<u>The FDD LTE Band 4 Test Mode</u> LTE Band 4 Link + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC11	<u>The FDD LTE Band 5 Test Mode</u> LTE Band 5 Link + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC12	<u>The FDD LTE Band 7 Test Mode</u> LTE Band 7 Link + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC13	<u>The FDD LTE Band 17 Test Mode</u> LTE Band 17 Link + Adapter + USB Cable + Battery + Bluetooth Link + GPS RX
TC14	<u>The FDD LTE Band 41 Test Mode</u> LTE Band 41 Link + Adapter + USB Cable + Battery + Bluetooth Link + GLONASS RX
TC15	<u>The BDS Test Mode</u> EUT+ Adapter + USB Cable + Battery + BDS RX
TC16	<u>The Idle Test Mode</u> GSM 850(Idle) + Adapter + Battery + USB Cable
Amusement Test Mode	
TC17	<u>The Camera Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card
TC18	<u>The Video Play Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card
TC19	<u>The USB Test Mode</u> EUT + USB Cable + Battery + Laptop+ TF Card
TC20	<u>The NFC Test Mode</u>

	EUT + Adapter + Battery + USB Cable+ NFC Link+ IC Card
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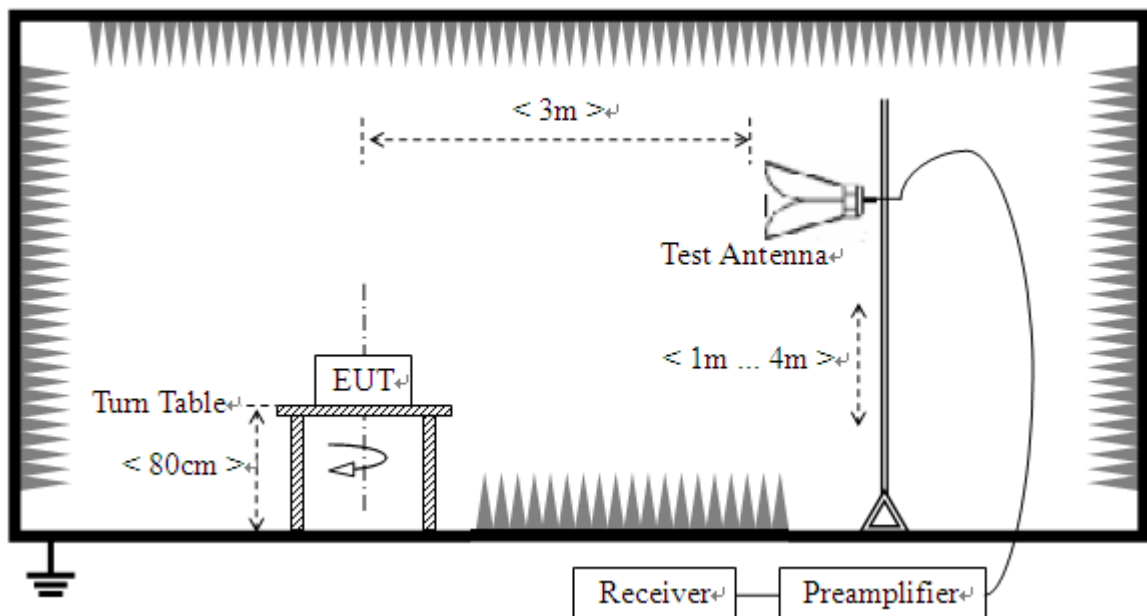
4.5 Test Setups

Test Setup 1



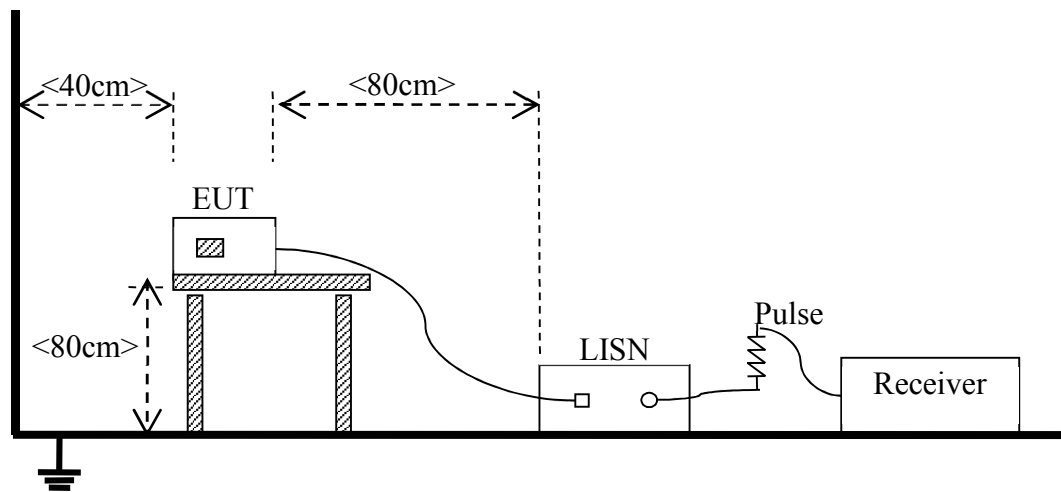
(For Radiated Emission Test (30 MHz-1 GHz))

Test Setup 2



(For Radiated Emission Test (above 1 GHz))

Test Setup 3



(For Conducted Emission, AC Ports Test)

4.6 Test Conditions

Test Case	Test Conditions	
Radiated Emission	Test Env.	NTNV
	Test Setup	Test Setup 1&2
	Test Configuration	TC01~TC20 ^{Note}
Conducted Emission	Test Env.	NTNV
	Test Setup	Test Setup 2
	Test Configuration	TC01~TC20 ^{Note}
Note: Based on client request, all normal using modes of the normal function were tested but only the worst test data of the worst mode is reported by this report. The GSM 850 MHz Test Mode is the worst mode in this report.		

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class B (at 10 m)	Class A (at 10 m)	
	Field Strength (μV/m)	Field Strength (dBμV/m)	Field Strength (dBμV/m)	Field Strength (μV/m)	Field Strength (dBμV/m)
30 - 88	100	40	30	90	39
88 - 216	150	43.5	33.5	150	43.5
216 - 960	200	46	36	210	46.4
Above 960	500	54	44	300	49.5

NOTE:

- 1) Field Strength (dBμV/m) = 20*log [Field Strength (μV/m)].
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) The limits using ANSI C63.4.

5.1.1.2 Test Setup

Refer to 4.5 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in Section 3(b) (ANSI C63.4);

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

5.1.1.4 Test Result

Please refer to ANNEX A.1.

NOTE:

1. Results (dBuV/m) = Reading (dBuV) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Over limit = Results – Limit.

5.1.2 Conducted Emission

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.5 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50 Ω /50 μ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.1.2.4 Test Result

Please refer to ANNEX A.2.

NOTE:

$$1. \text{ Results (dB}\mu\text{V/m)} = \text{Reading (dB}\mu\text{V)} + \text{Factor (dB/m)}$$

The reading level is calculated by software which is not shown in the sheet

$$2. \text{ Factor} = \text{Insertion loss} + \text{Cable loss}$$

$$3. \text{ Over limit} = \text{Results} - \text{Limit.}$$

ANNEX A TEST RESULTS

A.1 Radiated Emission

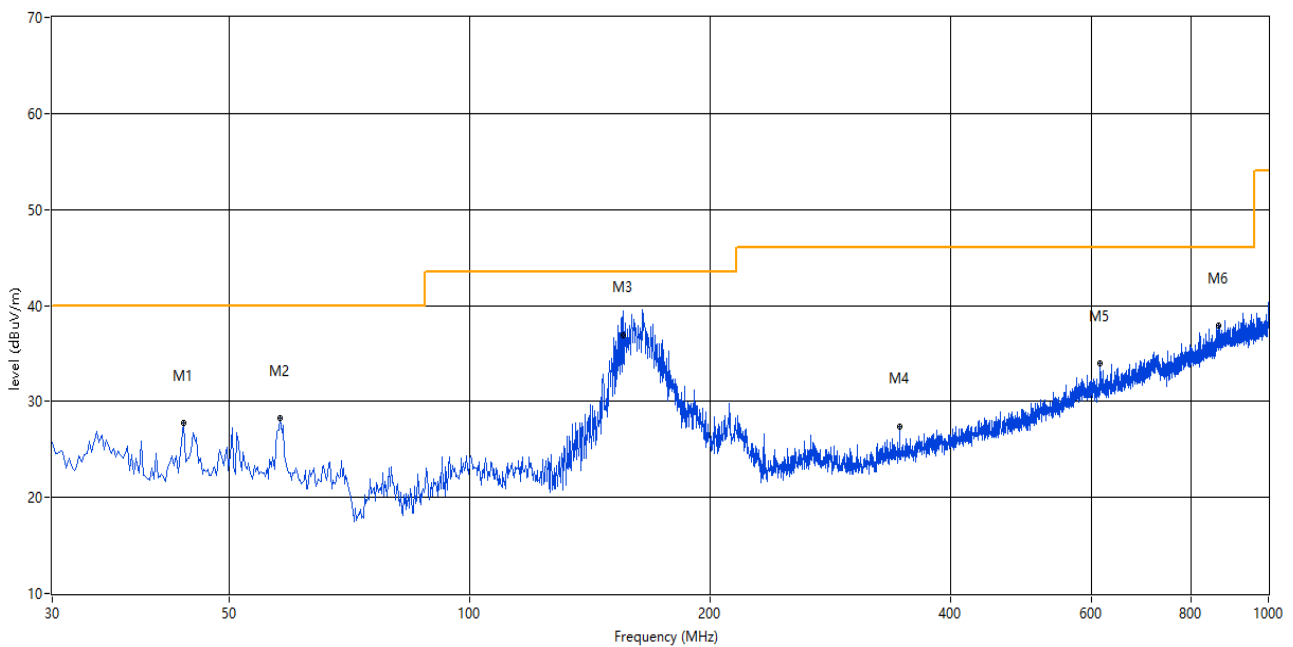
Note 1: The symbol of “--” in the table which means not application.

Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Test Data and Plots

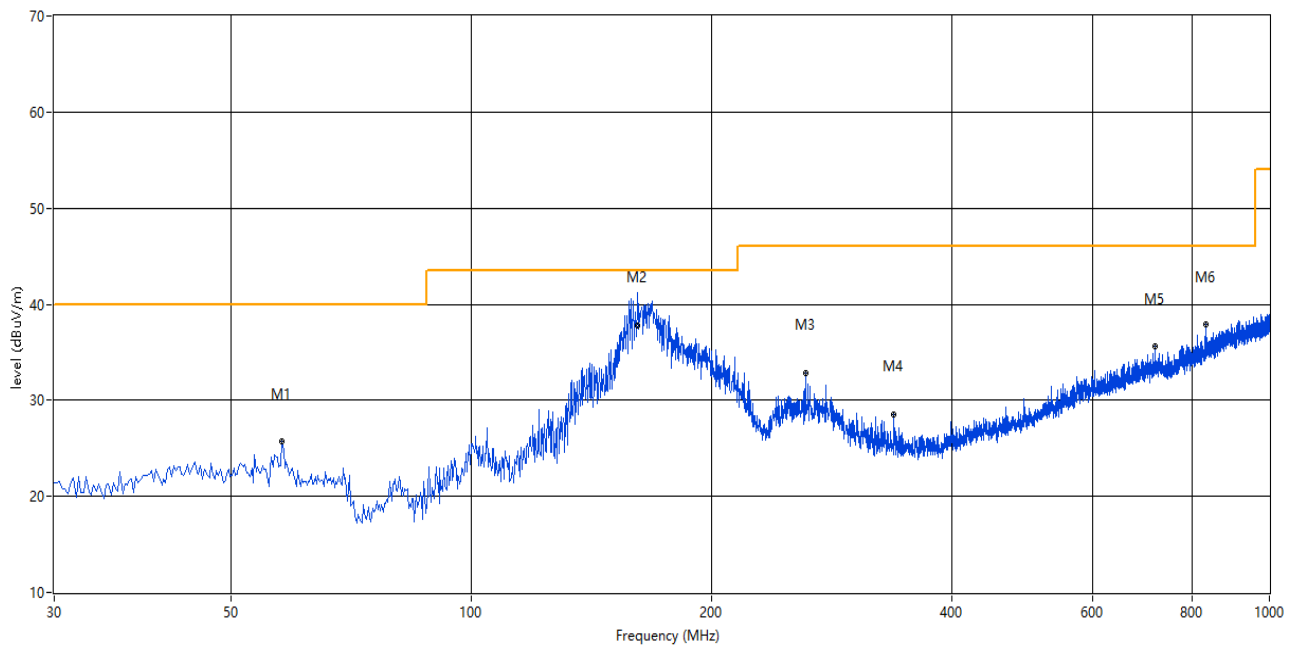
The GSM 850 MHz Test Mode

A.1.1 Test Antenna Vertical, 30 MHz – 1 GHz



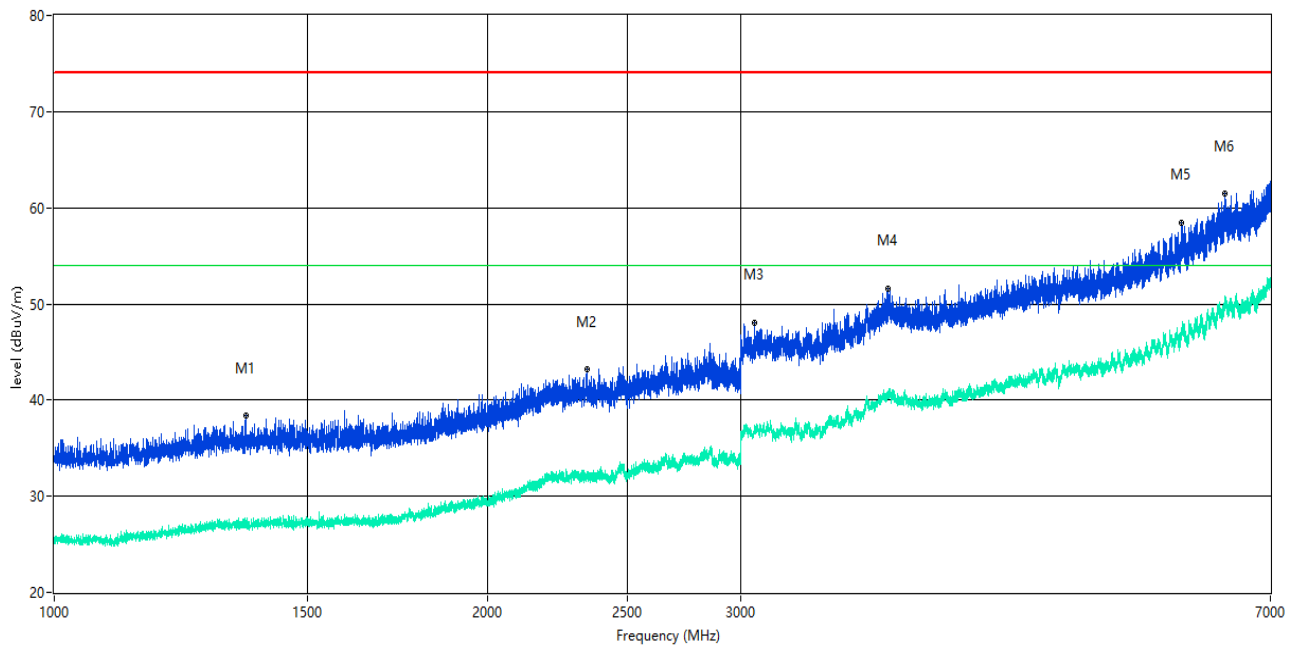
Frequency (MHz)	Peak Level (dBuV/m)	Q-peak Level (dBuV/m)	Average Level (dBuV/m)	Factor (dB)	PK Limit (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	Margin (dB)	Table (o)	Height (cm)	ANT	Verdict
43.819	27.75	--	--	-25.60	--	40.0	--	12.25	46.20	100	Vertical	Pass
57.881	28.27	--	--	-27.07	--	40.0	--	11.73	333.10	100	Vertical	Pass
155.584	39.37	36.85	--	-30.79	--	43.5	--	6.65	40.80	100	Vertical	Pass
345.414	27.33	--	--	-24.38	--	46.0	--	18.67	238.20	100	Vertical	Pass
615.491	33.98	--	--	-17.77	--	46.0	--	12.02	75.90	100	Vertical	Pass
866.173	37.88	--	--	-13.29	--	46.0	--	8.12	359.10	100	Vertical	Pass

A.1.2 Test Antenna Horizontal, 30 MHz – 1 GHz



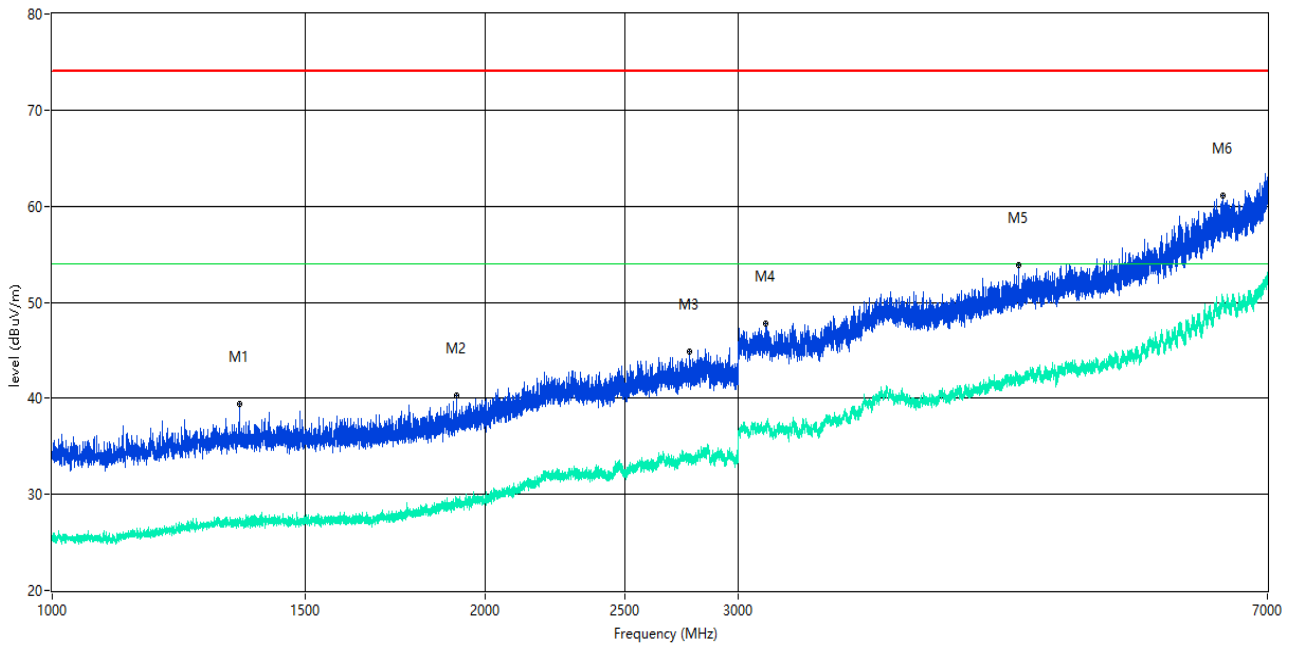
Frequency (MHz)	Peak Level (dBuV/m)	Q-peak Level (dBuV/m)	Average Level (dBuV/m)	Factor (dB)	PK Limit (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	Margin (dB)	Table (o)	Height (cm)	ANT	Verdict
57.881	25.73	--	--	-27.07	--	40.0	--	14.27	18.90	200	Horizontal	Pass
161.645	41.21	37.82	--	-30.52	--	43.5	--	5.68	129.90	200	Horizontal	Pass
262.014	32.82	--	--	-26.12	--	46.0	--	13.18	245.80	100	Horizontal	Pass
337.898	28.51	--	--	-24.55	--	46.0	--	17.49	256.50	100	Horizontal	Pass
719.498	35.65	--	--	-16.11	--	46.0	--	10.35	334.30	100	Horizontal	Pass
832.474	37.89	--	--	-13.98	--	46.0	--	8.11	283.40	100	Horizontal	Pass

A.1.3 Test Antenna Vertical, 1 GHz – 7 GHz



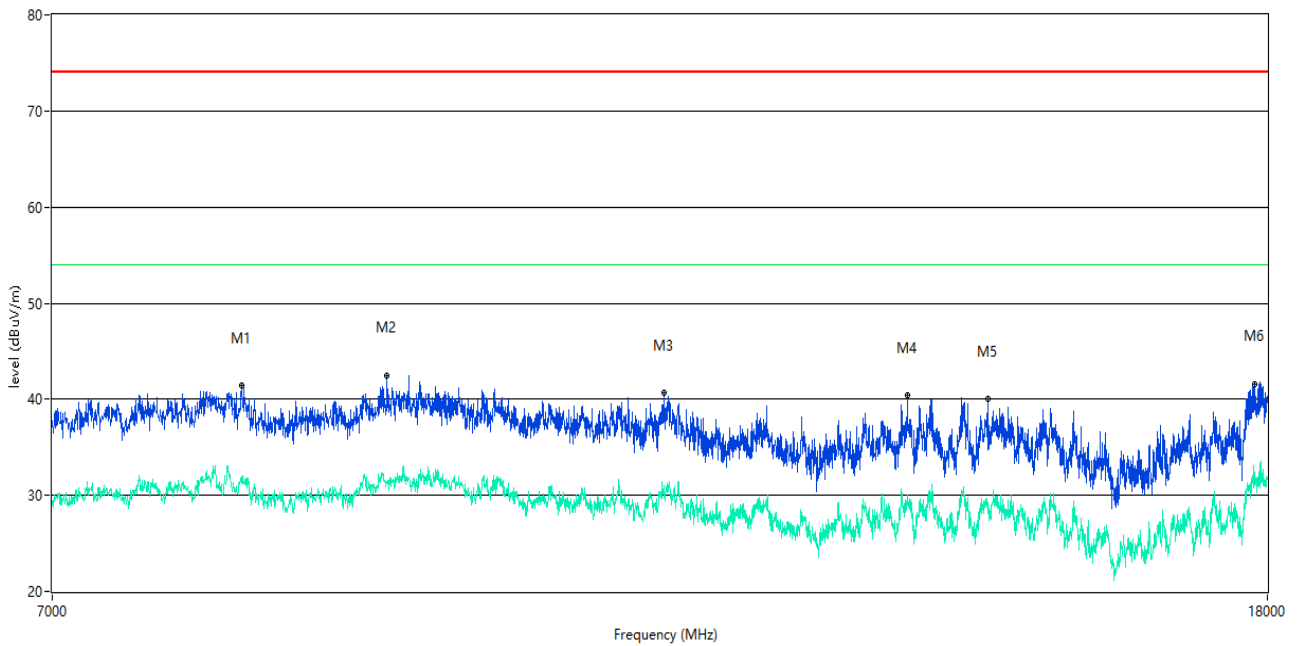
Frequency (MHz)	Peak Level (dBuV/m)	Q-peak Level (dBuV/m)	Average Level (dBuV/m)	Factor (dB)	PK Limit (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	Margin (dB)	Table (o)	Height (cm)	ANT	Verdict
1358.705	38.36	--	27.0	-13.23	74.0	--	54.0	27.00	343.00	150	Vertical	Pass
2346.332	43.23	--	32.2	-7.47	74.0	--	54.0	21.80	81.00	150	Vertical	Pass
3068.241	48.01	--	37.2	-2.40	74.0	--	54.0	16.80	159.00	150	Vertical	Pass
3796.025	51.52	--	40.4	0.84	74.0	--	54.0	13.60	166.00	150	Vertical	Pass
6075.866	58.49	--	47.0	8.90	74.0	--	54.0	7.00	359.00	150	Vertical	Pass
6512.311	61.53	--	50.5	12.32	74.0	--	54.0	3.50	160.00	150	Vertical	Pass

A.1.4 Test Antenna Horizontal, 1 GHz – 7 GHz



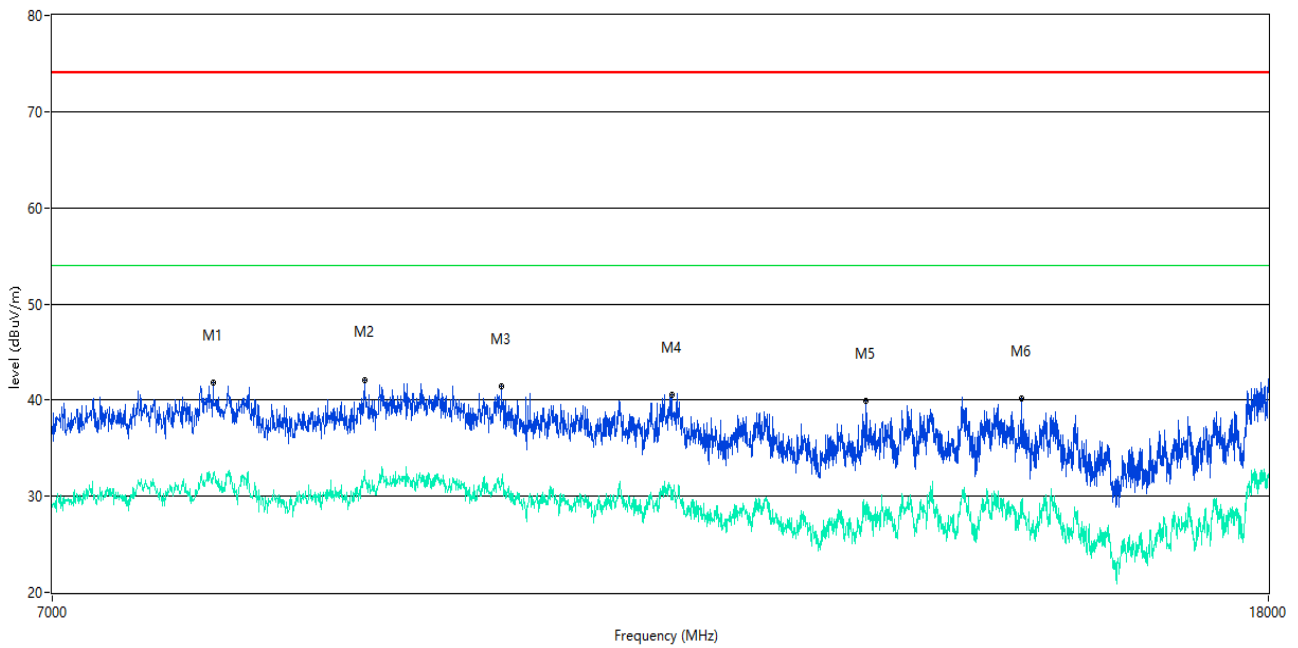
Frequency (MHz)	Peak Level (dBuV/m)	Q-peak Level (dBuV/m)	Average Level (dBuV/m)	Factor (dB)	PK Limit (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	Margin (dB)	Table (o)	Height (cm)	ANT	Verdict
1349.706	39.42	--	26.9	-13.22	74.0	--	54.0	27.10	94.00	150	Horizontal	Pass
1909.636	40.27	--	29.4	-11.11	74.0	--	54.0	24.60	287.00	150	Horizontal	Pass
2775.278	44.87	--	33.9	-5.89	74.0	--	54.0	20.10	280.00	150	Horizontal	Pass
3136.858	47.76	--	37.0	-2.23	74.0	--	54.0	17.00	267.00	150	Horizontal	Pass
4700.787	53.90	--	42.1	2.47	74.0	--	54.0	11.90	277.00	150	Horizontal	Pass
6515.311	61.07	--	49.8	12.17	74.0	--	54.0	4.20	317.00	150	Horizontal	Pass

A.1.5 Test Antenna Vertical, 7 GHz – 18 GHz



Frequency (MHz)	Peak Level (dBuV/m)	Q-peak Level (dBuV/m)	Average Level (dBuV/m)	Factor (dB)	PK Limit (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	Margin (dB)	Table (o)	Height (cm)	ANT	Verdict
8107.973	41.48	--	31.3	-24.85	74.0	--	54.0	22.70	116.00	150	Vertical	Pass
9081.230	42.46	--	31.3	-25.00	74.0	--	54.0	22.70	246.00	150	Vertical	Pass
11258.685	40.66	--	31.0	-19.73	74.0	--	54.0	23.00	12.00	150	Vertical	Pass
13603.849	40.38	--	30.0	-15.96	74.0	--	54.0	24.00	183.00	150	Vertical	Pass
14483.629	40.00	--	29.1	-13.87	74.0	--	54.0	24.90	168.00	150	Vertical	Pass
17826.793	41.61	--	32.5	-7.57	74.0	--	54.0	21.50	119.00	150	Vertical	Pass

A.1.6 Test Antenna Horizontal, 7 GHz – 18 GHz



Frequency (MHz)	Peak Level (dBuV/m)	Q-peak Level (dBuV/m)	Average Level (dBuV/m)	Factor (dB)	PK Limit (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	Margin (dB)	Table (o)	Height (cm)	ANT	Verdict
7929.268	41.78	--	32.0	-26.35	74.0	--	54.0	22.00	1.00	150	Horizontal	Pass
8921.770	42.11	--	32.7	-24.60	74.0	--	54.0	21.30	1.00	150	Horizontal	Pass
9922.519	41.38	--	31.2	-24.06	74.0	--	54.0	22.80	336.00	150	Horizontal	Pass
11324.669	40.50	--	30.7	-19.32	74.0	--	54.0	23.30	9.00	150	Horizontal	Pass
13172.207	39.94	--	29.0	-18.74	74.0	--	54.0	25.00	142.00	150	Horizontal	Pass
14854.786	40.17	--	29.0	-15.29	74.0	--	54.0	25.00	241.00	150	Horizontal	Pass

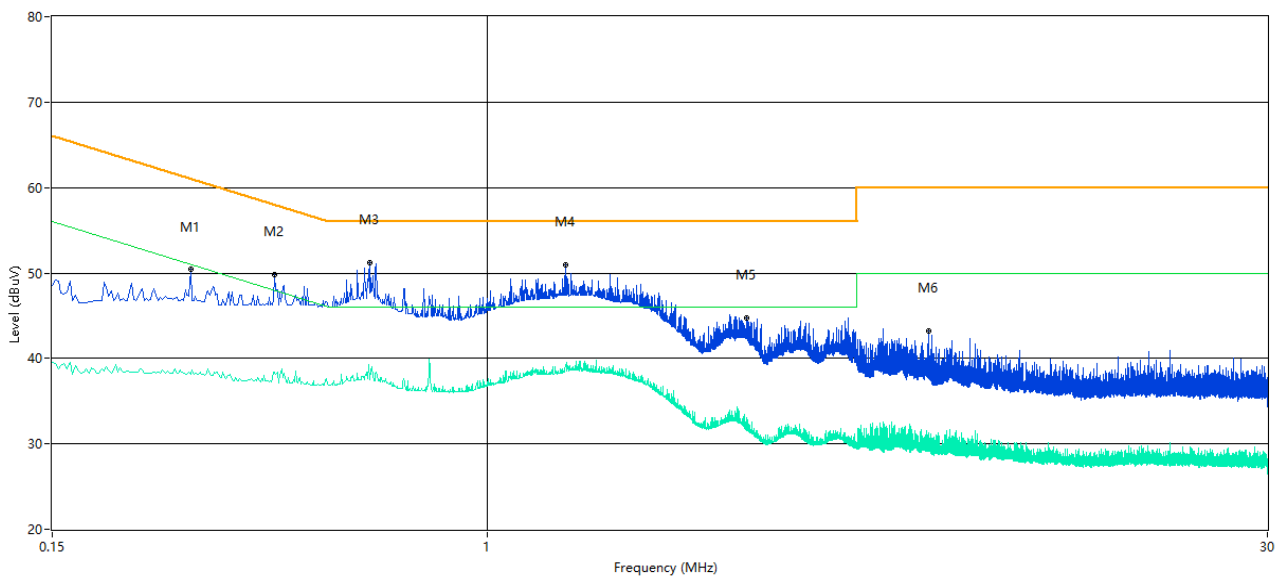
A.2 Conducted Emission

Test Data and Plots

The GSM 850 MHz Test Mode

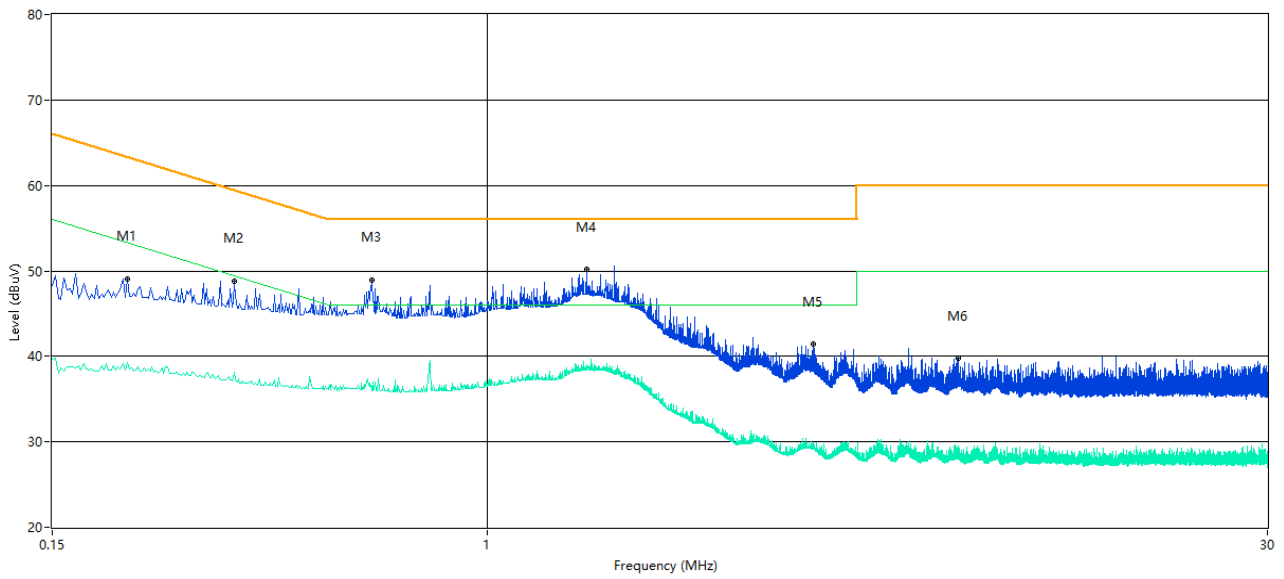
Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

A.2.1 L Phase



Frequency (MHz)	Peak Level (dBuV)	Q-peak Level (dBuV)	Average Level (dBuV)	Factor (dB)	QP Limit (dBuV)	AV Limit (dBuV)	Margin (dB)	Line	Verdict
0.274	42.77	37.65	29.25	10.53	61.0	51.0	21.75	L Line	Pass
0.396	44.92	41.07	31.47	10.53	57.9	47.9	16.43	L Line	Pass
0.600	50.04	45.07	34.62	10.53	56.0	46.0	10.93	L Line	Pass
1.406	44.85	38.36	29.81	10.54	56.0	46.0	16.19	L Line	Pass
3.092	43.41	36.90	27.59	10.56	56.0	46.0	18.41	L Line	Pass
6.846	39.20	32.57	23.24	10.60	60.0	50.0	26.76	L Line	Pass

A.2.2 N Phase



Frequency (MHz)	Peak Level (dBuV)	Q-peak Level (dBuV)	Average Level (dBuV)	Factor (dB)	QP Limit (dBuV)	AV Limit (dBuV)	Margin (dB)	Line	Verdict
0.208	48.46	35.72	24.34	10.53	63.3	53.3	27.58	N Line	Pass
0.332	40.57	33.66	24.15	10.53	59.4	49.4	25.25	N Line	Pass
0.604	46.03	39.01	27.57	10.53	56.0	46.0	16.99	N Line	Pass
1.540	39.94	30.83	23.04	10.55	56.0	46.0	22.96	N Line	Pass
4.144	38.84	30.68	20.07	10.58	56.0	46.0	25.32	N Line	Pass
7.784	34.67	27.13	18.44	10.61	60.0	50.0	31.56	N Line	Pass

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-EC1930222-AE.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL-EC1930222-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL-EC1930222-AI.PDF”.

--END OF REPORT--